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/ Ruth Montalvo

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Docket No.

JG-SU-5196 / 500577.20055

Applicant(s):

Kazuhiro HARADA, Yoji SUZUKI and Hidenobu ABE

Application No.:

Filed:

concurrently herewith -January 30, 2004

For:

METHOD OF MANUFACTURING SILICON SINGLE CRYSTAL AND SILICON SINGLE CRYSTAL MANUFACTURED BY THE METHOD

Commissioner of Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

SIR:

Applicant herewith submits together with the simultaneously patent application this Information Disclosure Statement in accordance with the provisions of 37 C.F.R. §§ 1.97 and 1.98, and hereby make of record the following references:

Document Number

Date

Name and/or Country

English Translation

Date: 01/30/04

AA 6,045,610

04/04/2000

Park, et al.

AL

11-1393

01/06/1999

JAPAN

English Abstract of Publication No. 2000-199048

Accompanying this Information Disclosure Statement and form PTO-1449 are copies of the AA and JP Publication of AL with English Abstract. Documents AA and AL are mentioned on page 3 of the specification.

This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,

01/30/04 JEG:ram

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Enclosures:

PTO-1449 2 documents English Abstract Jules (E) Goldberg

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LIST OF PRIOR ART CITED BY APPLICANT (Filed on January30, 2004)

Docket No. JG-SU-5196 / 500577.20055 Applicant(s): Kazuhiro HARADA, Yoji SUZUKI and Hidenobu ABE Application No. Group: Filed: concurrently herewith -January 30, 2004 Examiner: **U.S. PATENT DOCUMENTS** Exam. Document Sub-Filing Date Number Date Init Name Class Class Appropriate AA 6,045,610 04/04/2000 Park, et al. **AB** AC **AD** AE AF AG AH Al AJ ΑK FOREIGN PATENT DOCUMENTS Document Sub-Translation **CLASS** Number Country Class YES NO AL 11-1393 01/06/1999 **JAPAN Abstract only** 2000-199048 AM AN **AO** AP **AQ AR AS** OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.) **AV** AW

Examiner: Date:

AX AY AZ

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.